

# FCA22N60N

## N-Channel MOSFET

### 600V, 22A, 0.165Ω

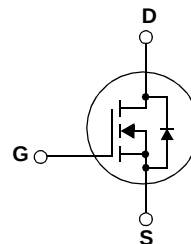
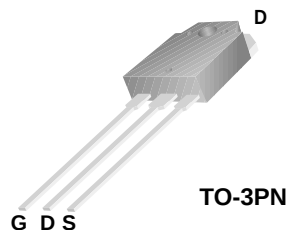
#### Features

- $R_{DS(on)} = 0.140\Omega$  (Typ.) @  $V_{GS} = 10V$ ,  $I_D = 11A$
- $BV_{DSS} > 650V$  @  $T_J = 150^\circ C$
- Ultra Low Gate Charge (Typ.  $Q_g = 45nC$ )
- Low Effective Output Capacitance
- 100% Avalanche Tested
- RoHS Compliant



#### Description

The SupreMOS MOSFET, Fairchild's next generation of high voltage super-junction MOSFETs, employs a deep trench filling process that differentiates it from preceding multi-epi based technologies. By utilizing this advanced technology and precise process control, SupreMOS provides world class Rsp, superior switching performance and ruggedness. This SupreMOS MOSFET fits the industry's AC-DC SMPS requirements for PFC, server/telecom power, FPD TV power, ATX power, and industrial power applications.



#### MOSFET Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted\*

| Symbol         | Parameter                                                                    | FCA22N60N                          | Units        |
|----------------|------------------------------------------------------------------------------|------------------------------------|--------------|
| $V_{DSS}$      | Drain to Source Voltage                                                      | 600                                | V            |
| $V_{GSS}$      | Gate to Source Voltage                                                       | $\pm 30$                           | V            |
| $I_D$          | Drain Current                                                                | Continuous ( $T_C = 25^\circ C$ )  | A            |
|                |                                                                              | Continuous ( $T_C = 100^\circ C$ ) |              |
| $I_{DM}$       | Drain Current Pulsed (Note 1)                                                | 66                                 | A            |
| $E_{AS}$       | Single Pulsed Avalanche Energy (Note 2)                                      | 672                                | mJ           |
| $I_{AR}$       | Avalanche Current                                                            | 7.3                                | A            |
| $E_{AR}$       | Repetitive Avalanche Energy                                                  | 2.75                               | mJ           |
| $dv/dt$        | Peak Diode Recovery $dv/dt$ (Note 3)                                         | 20                                 | V/ns         |
|                | MOSFET $dv/dt$                                                               | 100                                |              |
| $P_D$          | Power Dissipation                                                            | ( $T_C = 25^\circ C$ )             | W            |
|                |                                                                              | Derate above $25^\circ C$          | $W/^\circ C$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                      | -55 to +150                        | $^\circ C$   |
| $T_L$          | Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds | 300                                | $^\circ C$   |

\*Drain current limited by maximum junction temperature

#### Thermal Characteristics

| Symbol          | Parameter                                       | FCA22N60N | Units        |
|-----------------|-------------------------------------------------|-----------|--------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case            | 0.61      | $^\circ C/W$ |
| $R_{\theta JS}$ | Thermal Resistance, Case to Heat Sink (Typical) | 0.24      |              |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient         | 40        |              |

**Package Marking and Ordering Information**  $T_C = 25^\circ\text{C}$  unless otherwise noted

| Device Marking | Device    | Package | Reel Size | Tape Width | Quantity |
|----------------|-----------|---------|-----------|------------|----------|
| FCA22N60N      | FCA22N60N | TO-3PN  | -         | -          | 30       |

**Electrical Characteristics**

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|--------|-----------|-----------------|------|------|------|-------|
|--------|-----------|-----------------|------|------|------|-------|

**Off Characteristics**

|                                      |                                           |                                                                 |     |      |           |                    |
|--------------------------------------|-------------------------------------------|-----------------------------------------------------------------|-----|------|-----------|--------------------|
| $BV_{DSS}$                           | Drain to Source Breakdown Voltage         | $I_D = 1\text{mA}, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$  | 600 | -    | -         | V                  |
|                                      |                                           | $I_D = 1\text{mA}, V_{GS} = 0\text{V}, T_J = 150^\circ\text{C}$ | 650 | -    | -         |                    |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 1\text{mA}$ , Referenced to $25^\circ\text{C}$           | -   | 0.68 | -         | $V/^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = 480\text{V}, V_{GS} = 0\text{V}$                      | -   | -    | 10        | $\mu\text{A}$      |
|                                      |                                           | $V_{DS} = 480\text{V}, T_J = 125^\circ\text{C}$                 | -   | -    | 100       |                    |
| $I_{GSS}$                            | Gate to Body Leakage Current              | $V_{GS} = \pm 50\text{V}, V_{DS} = 0\text{V}$                   | -   | -    | $\pm 100$ | nA                 |

**On Characteristics**

|              |                                      |                                         |     |       |       |          |
|--------------|--------------------------------------|-----------------------------------------|-----|-------|-------|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage               | $V_{GS} = V_{DS}, I_D = 250\mu\text{A}$ | 2.0 | 3     | 4.0   | V        |
| $R_{DS(on)}$ | Static Drain to Source On Resistance | $V_{GS} = 10\text{V}, I_D = 11\text{A}$ | -   | 0.140 | 0.165 | $\Omega$ |
| $g_{FS}$     | Forward Transconductance             | $V_{DS} = 20\text{V}, I_D = 11\text{A}$ | -   | 22    | -     | S        |

**Dynamic Characteristics**

|                      |                                    |                                                                                |   |       |   |          |
|----------------------|------------------------------------|--------------------------------------------------------------------------------|---|-------|---|----------|
| $C_{iss}$            | Input Capacitance                  | $V_{DS} = 100\text{V}, V_{GS} = 0\text{V}$<br>$f = 1\text{MHz}$                | - | 1950  | - | pF       |
| $C_{oss}$            | Output Capacitance                 |                                                                                | - | 75.9  | - | pF       |
| $C_{rss}$            | Reverse Transfer Capacitance       |                                                                                | - | 3     | - | pF       |
| $C_{oss}$            | Output Capacitance                 | $V_{DS} = 380\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$                    | - | 43.2  | - | pF       |
| $C_{oss\text{eff.}}$ | Effective Output Capacitance       | $V_{DS} = 0\text{V to } 480\text{V}, V_{GS} = 0\text{V}$                       | - | 196.4 | - | pF       |
| $Q_{g(tot)}$         | Total Gate Charge at 10V           | $V_{DS} = 380\text{V}, I_D = 11\text{A},$<br>$V_{GS} = 10\text{V}$<br>(Note 4) | - | 45    | - | nC       |
| $Q_{gs}$             | Gate to Source Gate Charge         |                                                                                | - | 8.7   | - | nC       |
| $Q_{gd}$             | Gate to Drain "Miller" Charge      |                                                                                | - | 14.5  | - | nC       |
| ESR                  | Equivalent Series Resistance (G-S) | Drain Open, $f = 1\text{MHz}$                                                  | - | 1     | - | $\Omega$ |

**Switching Characteristics**

|              |                     |                                                                           |   |      |   |    |
|--------------|---------------------|---------------------------------------------------------------------------|---|------|---|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 380\text{V}, I_D = 11\text{A}$<br>$R_G = 4.7\Omega$<br>(Note 4) | - | 16.9 | - | ns |
| $t_r$        | Turn-On Rise Time   |                                                                           | - | 16.7 | - | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |                                                                           | - | 49   | - | ns |
| $t_f$        | Turn-Off Fall Time  |                                                                           | - | 4    | - | ns |

**Drain-Source Diode Characteristics**

|                 |                                                          |                                                                              |   |     |     |    |
|-----------------|----------------------------------------------------------|------------------------------------------------------------------------------|---|-----|-----|----|
| I <sub>S</sub>  | Maximum Continuous Drain to Source Diode Forward Current |                                                                              | - | -   | 22  | A  |
| I <sub>SM</sub> | Maximum Pulsed Drain to Source Diode Forward Current     |                                                                              | - | -   | 66  | A  |
| V <sub>SD</sub> | Drain to Source Diode Forward Voltage                    | V <sub>GS</sub> = 0V, I <sub>SD</sub> = 11A                                  | - | -   | 1.2 | V  |
| t <sub>rr</sub> | Reverse Recovery Time                                    | V <sub>GS</sub> = 0V, I <sub>SD</sub> = 11A<br>dI <sub>F</sub> /dt = 100A/μs | - | 350 | -   | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge                                  |                                                                              | - | 6   | -   | μC |

**Notes:**

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $I_{AS} = 7.3\text{A}$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 22\text{A}$ ,  $dI/dt \leq 200\text{A}/\mu\text{s}$ ,  $V_{DD} \leq 380\text{V}$ , Starting  $T_J = 25^\circ\text{C}$
4. Essentially Independent of Operating Temperature Typical Characteristics

## Typical Performance Characteristics

Figure 1. On-Region Characteristics

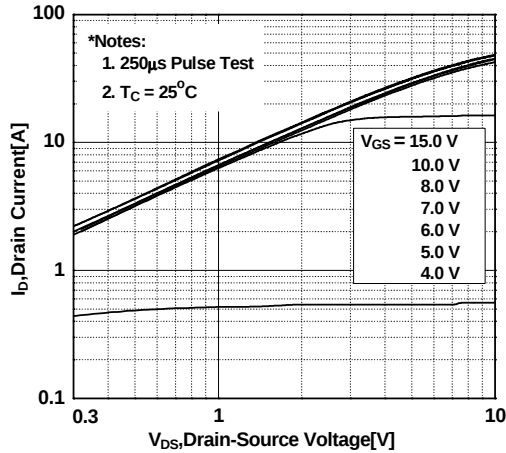


Figure 2. Transfer Characteristics

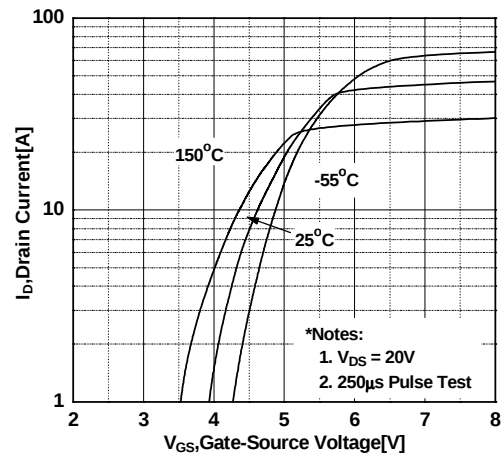


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

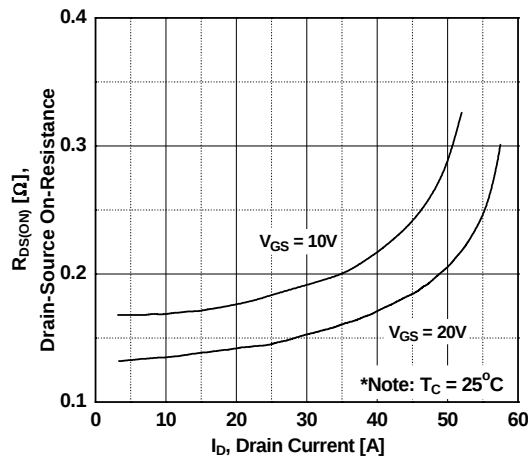


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

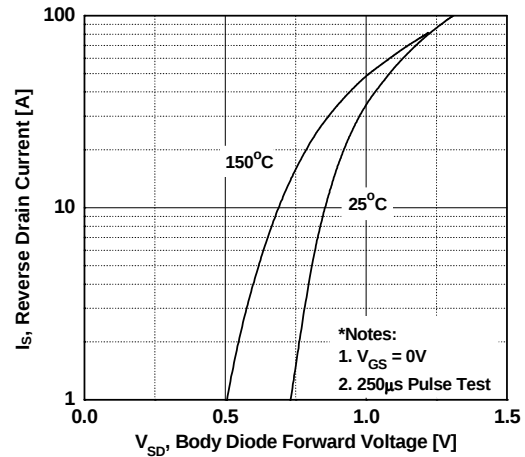


Figure 5. Capacitance Characteristics

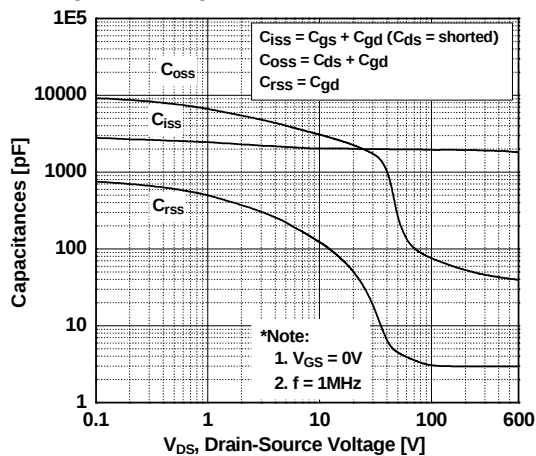
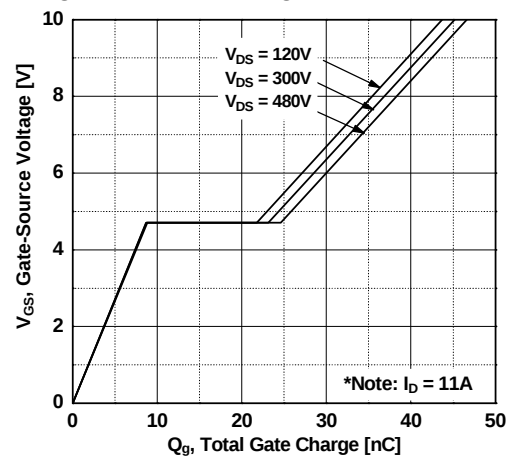


Figure 6. Gate Charge Characteristics



# Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

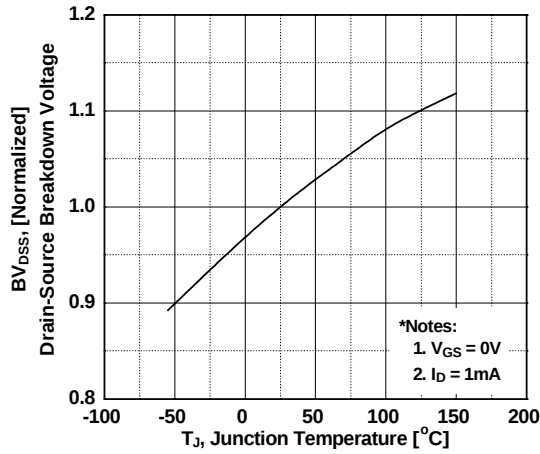


Figure 8. On-Resistance Variation vs. Temperature

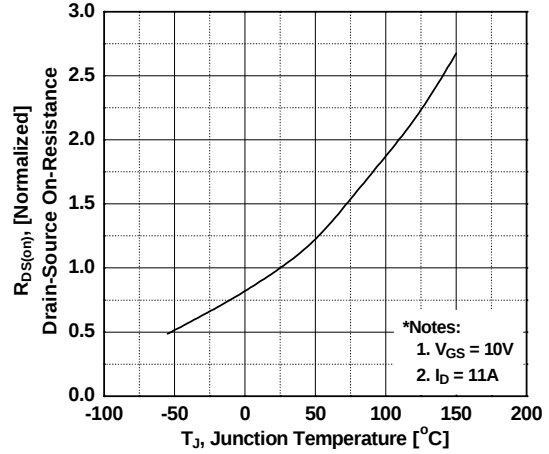


Figure 9. Maximum Safe Operating Area

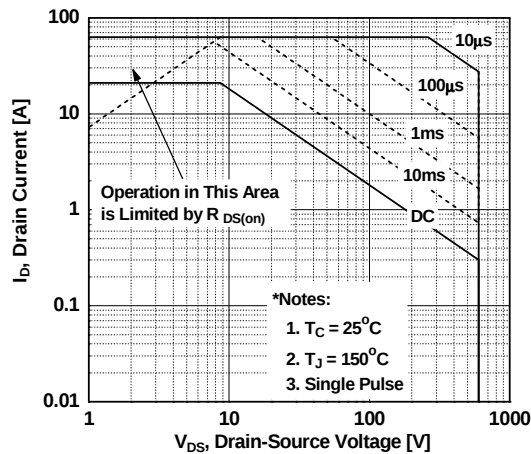


Figure 10. Maximum Drain Current vs. Case Temperature

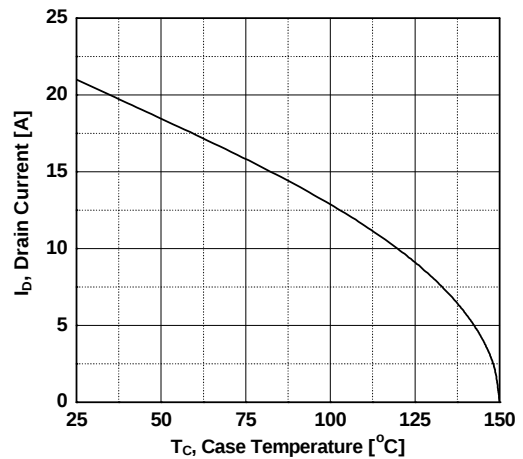
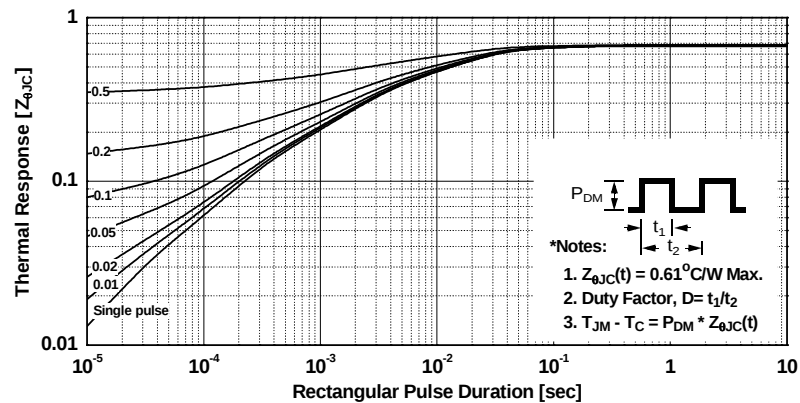
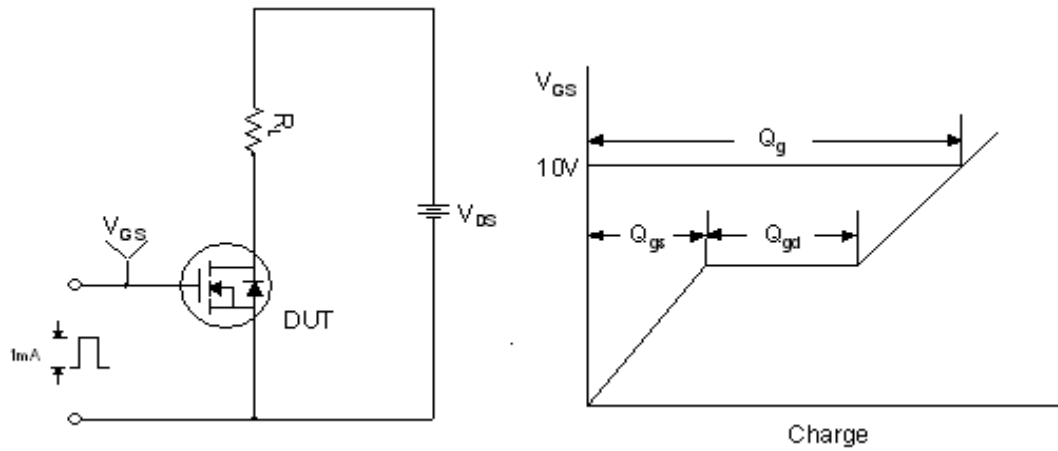


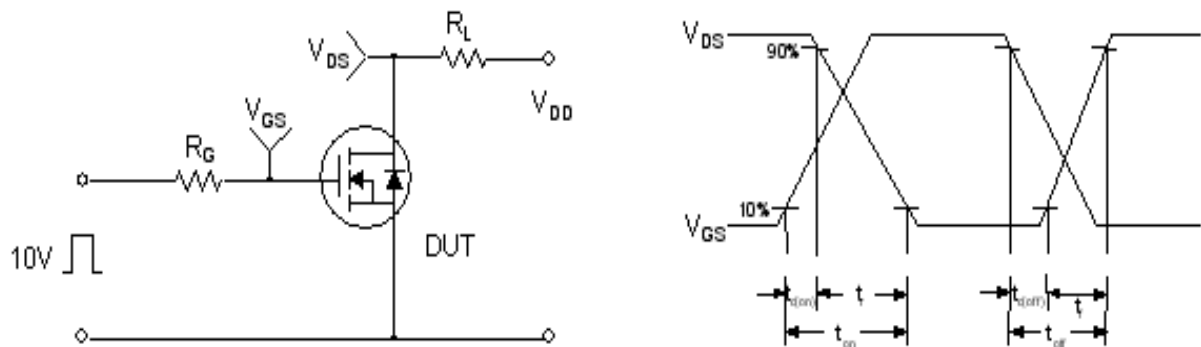
Figure 11. Transient Thermal Response Curve



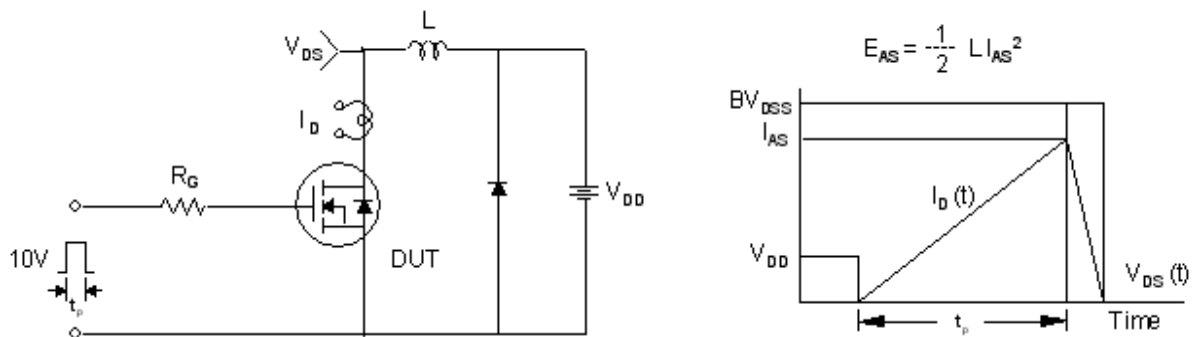
Gate Charge Test Circuit & Waveform



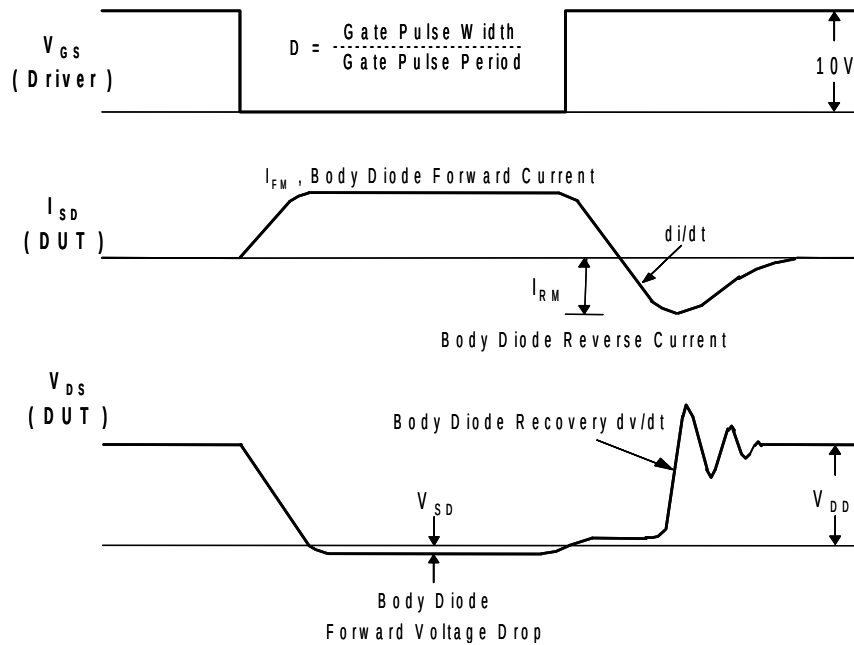
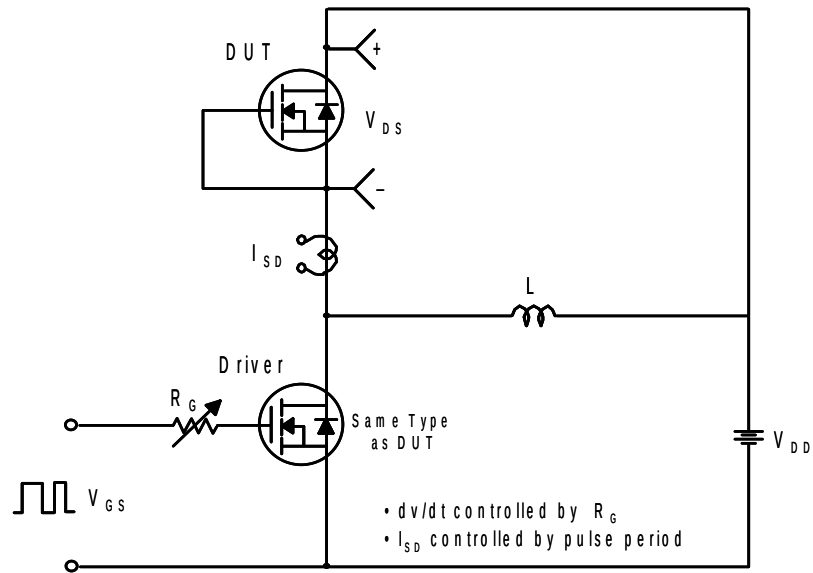
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

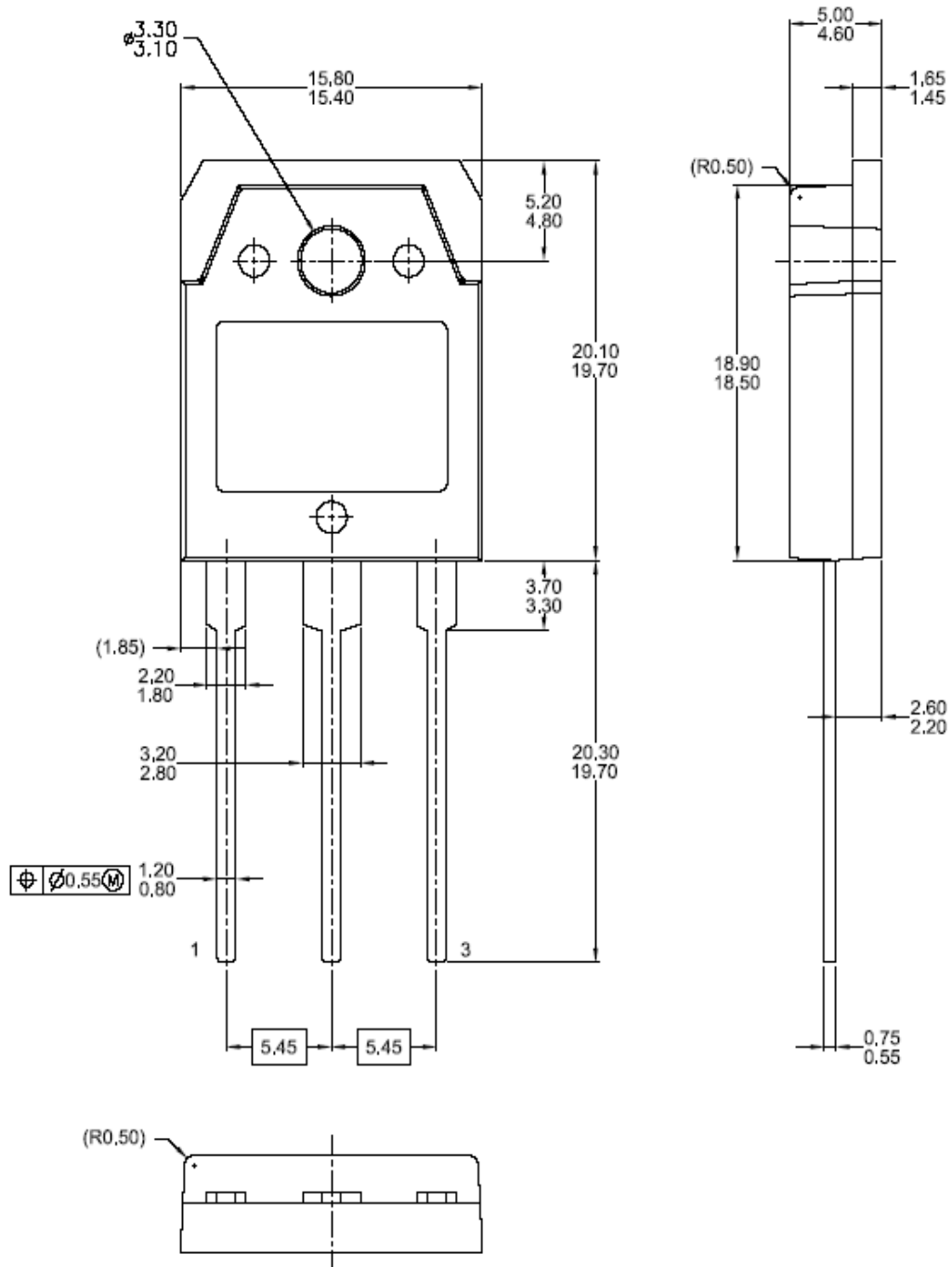


# Peak Diode Recovery dv/dt Test Circuit & Waveforms



## Mechanical Dimensions

## TO-3PN



Dimensions in Millimeters



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